Form PTO 1449		U.S. DEPARTMENT	OF COMMERCE	ATTY DOCKET NO. 244838US2S		SERIAL NO. 10/699,676			
(Modified)		PATENT AND TRA	DEMARK OFFICE						
		PE		APPLICANT					
LIST OF	REFE	RECES CITED BY	PLICANT	Takashi YAMADA, et al.					
		RESCES CITED BY ARPLICANT		FILING DATE		GROUP			
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		OTHER R	EFERENCES (Including Author, Title, Date, Pertinen	t Pages, e	tc.)			
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-	AZ Additional References sheet(s							neet(s) attached	
Examiner						Date Considered 6-8-85			
*Examiner: In	itial if r	eference is considered.	whether or no	t citation is in conformance with MPEP 6	09; Draw li	ne through	citation i	not in	
conformance and not considered. Include copy of this form with next communication to applicant.									

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